

VECTORIAL SECOND-HARMONIC GENERATION IMAGING WITH BESSEL BEAMS

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Bessel beams, the so-called non-diffractive beams, exhibit a very long depth of focus [1]. This unique property was found to be useful for imaging extended materials in three-dimensions without the need for sequential axial scanning. So far, the earlier imaging techniques have focused on volumetric imaging of samples and neglected the vectorial character of the focal fields [2, 3]. As the nonlinear optical response of nanostructures is strongly polarization dependent, the character of the driving fields become especially important [4, 5].

Here, we demonstrate SHG microscopy using linearly polarized Bessel beams. We synthesized a quasi-Bessel beam by displaying an axicon phase on a spatial light modulator. The resulting beam was then directed toward a microscope objective (NA=0.8) to generate a Bessel beam at the focus. Using vertically-aligned GaAs nanowires (length ≈ 2 μm , diameter ≈ 55 nm), we found that the spatial distribution of the longitudinal electric fields of a focused Bessel beam is similar to a Gaussian beam. Additionally, we found that the Bessel beam excitation is more robust in the longitudinal (z) direction than standard SHG microscopies that rely on focused linear polarizations.

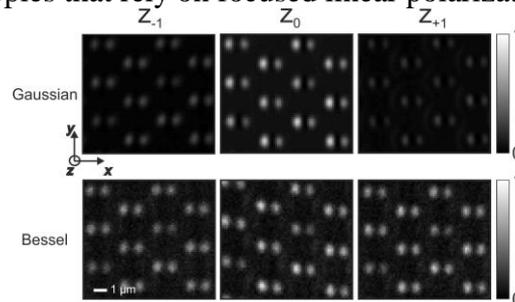


Figure 1. SHG intensity maps of GaAs nanowires using linearly polarized (x) Gaussian (top row) and Bessel (bottom) beams for different axial (z) positions. Scale bar = 1 μm .

Our results open new ways for efficient excitation of axially extended nonlinear nano-objects.

[1] J. Durnin, [Journal of the Optical Society of America A 4 \(1987\) 651-654](#).

[2] E.J. Botcherby et al., [Optics Communications 267 \(2006\) 253-260](#).

[3] N. Vuillemin et al., [Scientific Reports 6 \(2016\) 29863](#).

[4] G. Bautista et al., [Nano Letters 15 \(2015\) 1564-1569](#).

[5] L. Turquet et al., [Laser and Photonics Reviews 11 \(2016\) 1600175](#).